## DISCRETE SEMICONDUCTORS

## DATA SHEET

# **BFG31**PNP 5 GHz wideband transistor

Product specification Supersedes data of November 1992 1995 Sep 12



## PNP 5 GHz wideband transistor

BFG31

## **FEATURES**

- High output voltage capability
- High gain bandwidth product
- · Good thermal stability
- Gold metallization ensures excellent reliability.

## **DESCRIPTION**

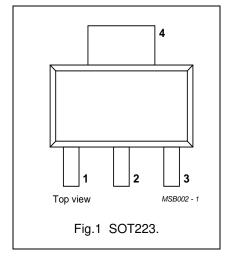
PNP planar epitaxial transistor mounted in a plastic SOT223 envelope.

It is intended for wideband amplifier applications.

NPN complement is the BFG97.

## **PINNING**

PIN	DESCRIPTION	
1	emitter	
2	base	
3	emitter	
4	collector	



## **QUICK REFERENCE DATA**

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>CEO</sub>	collector-emitter voltage	open base	-	_	-15	٧
Ic	DC collector current		_	_	-100	mA
P <sub>tot</sub>	total power dissipation	up to $T_s = 135 ^{\circ}\text{C}$ ; note 1	_	_	1	W
h <sub>FE</sub>	DC current gain	$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ $T_{amb} = 25 ^{\circ}\text{C}$	25	_	_	
f <sub>T</sub>	transition frequency	$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 500 MHz; $T_{amb} = 25 \text{ °C}$	_	5.0	_	GHz
G <sub>UM</sub>	maximum unilateral power gain	$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 800 MHz; $T_{amb} = 25 \text{ °C}$	_	12	_	dB
Vo	output voltage	$I_{C} = -100 \text{ mA}; V_{CE} = -10 \text{ V};$ $R_{L} = 75 \Omega; T_{amb} = 25 \text{ °C}$	_	600	_	mV

## **LIMITING VALUES**

In accordance with the Absolute Maximum System (IEC 134).

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V <sub>CBO</sub>	collector-base voltage	open emitter	_	-20	V
V <sub>CEO</sub>	collector-emitter voltage	open base	_	-15	٧
V <sub>EBO</sub>	emitter-base voltage	open collector	_	-3	٧
Ic	DC collector current		_	-100	mA
P <sub>tot</sub>	total power dissipation	up to T <sub>s</sub> = 135 °C; note 1	_	1	W
T <sub>stg</sub>	storage temperature		-65	150	°C
Tj	junction temperature		_	175	°C

## Note

1.  $T_s$  is the temperature at the soldering point of the collector tab.

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## THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	THERMAL RESISTANCE	
R <sub>th j-s</sub>	thermal resistance from junction to soldering point	up to T <sub>s</sub> = 135 °C; note 1	40 K/W	

#### Note

1.  $T_s$  is the temperature at the soldering point of the collector tab.

## **CHARACTERISTICS**

T<sub>i</sub> = 25 °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
V <sub>(BR)CBO</sub>	collector-base breakdown voltage	open emitter; I <sub>C</sub> = −10 mA	-20	-	_	٧
V <sub>(BR)CEO</sub>	collector-emitter breakdown voltage	open base; $I_C = -10 \text{ mA}$	-18	_	-	V
$V_{(BR)EBO}$	emitter-base breakdown voltage	open collector; I <sub>E</sub> = -0.1 mA	-3	-	_	V
I <sub>CBO</sub>	collector cut-off current	$I_E = 0; V_{CB} = -10 \text{ V}$	_	_	-1	μА
h <sub>FE</sub>	DC current gain	$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ $T_{amb} = 25 \text{ °C}$	25	_	_	
C <sub>cb</sub>	collector-base capacitance	$I_C = 0$ ; $V_{CB} = -10 \text{ V}$ ; $f = 1 \text{ MHz}$ ;	_	1.8	_	pF
C <sub>eb</sub>	emitter-base capacitance	$I_C = 0$ ; $V_{EB} = -10 \text{ V}$ ; $f = 1 \text{ MHz}$	_	5	-	pF
C <sub>re</sub>	feedback capacitance	$I_C = 0$ ; $V_{CE} = -10 \text{ V}$ ; $f = 1 \text{ MHz}$ ; $T_{amb} = 25 \text{ °C}$	_	1.6	_	pF
f <sub>T</sub>	transition frequency	$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 500 MHz; $T_{amb} = 25 ^{\circ}\text{C}$	_	5	_	GHz
G <sub>UM</sub>	maximum unilateral power gain; note 1	$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ $f = 500 \text{ MHz}; T_{amb} = 25 ^{\circ}\text{C}$	_	16	-	dB
		$I_C = -70 \text{ mA}; V_{CE} = -10 \text{ V};$ f = 800 MHz; $T_{amb} = 25 ^{\circ}\text{C}$	_	12	_	dB
Vo	output voltage	note 2	_	600	_	mV
Vo	output voltage	note 3	_	550	_	mV

## **Notes**

1.  $G_{UM}$  is the maximum unilateral power gain, assuming  $S_{12}$  is zero and  $G_{UM} = 10 \log \frac{\left|s_{21}\right|^2}{(1-\left|s_{11}\right|^2)(1-\left|s_{22}\right|^2)} dB$ .

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2.  $d_{im} = -60 \text{ dB}$ ;  $I_C = -70 \text{ mA}$ ;  $V_{CE} = -10 \text{ V}$ ;  $R_L = 75 \Omega$ ;  $T_{amb} = 25 \,^{\circ}\text{C}$ ;

 $V_p = V_o$  at  $d_{im} = -60$  dB;  $f_p = 850.25$  MHz;

 $V_q = V_o -6 \text{ dB}; f_q = 858.25 \text{ MHz};$ 

 $V_r = V_o - 6 \text{ dB}$ ;  $f_r = 860.25 \text{ MHz}$ ;

measured at  $f_{(p+q-r)} = 848.25 \text{ MHz}.$ 

3.  $d_{im} = -60 \text{ dB (DIN 45004B)}$ ;  $I_C = -70 \text{ mA}$ ;  $V_{CE} = -10 \text{ V}$ ;  $R_L = 75 \Omega$ ;  $T_{amb} = 25 \,^{\circ}\text{C}$ ;

 $V_p = V_o = at d_{im} = -60 dB$ ;  $f_p = 445.25 MHz$ ;

 $V_q = V_o -6 dB$ ;  $f_q = 453.25 MHz$ ;

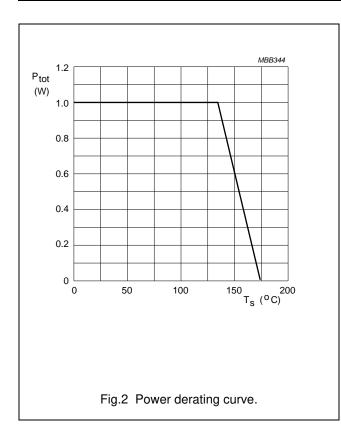
 $V_r = V_o -6 \text{ dB}$ ;  $f_r = 455.25 \text{ MHz}$ ;

measured at  $f_{(p+q-r)} = 443.25$  MHz.

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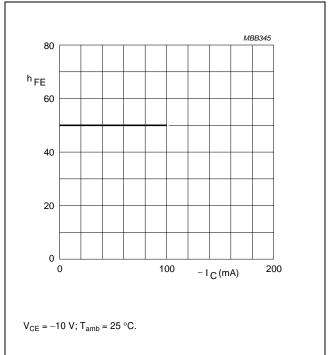
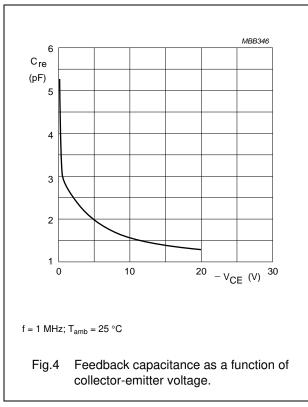
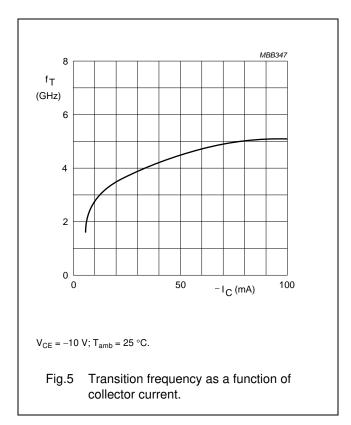


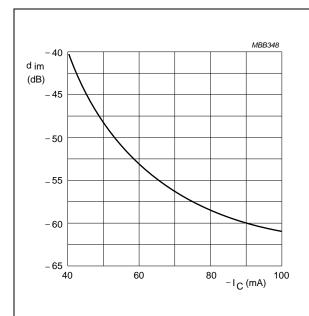
Fig.3 DC current gain as a function of collector current.





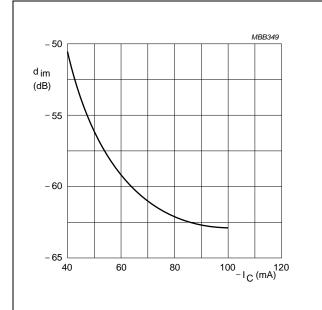
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 $V_{CE} = -10 \text{ V; } V_o = 650 \text{ mV; } T_{amb} = 25 \text{ °C; } \\ f_{(p+q-r)} = 443.25 \text{ MHz.}$ 

Fig.6 Intermodulation distortion as a function of collector current.



 $V_{CE} = -10 \text{ V; } V_o = 550 \text{ mV; } T_{amb} = 25 \text{ °C; } \\ f_{(p+q-r)} = 848.25 \text{ MHz.}$ 

Fig.7 Intermodulation distortion as a function of collector current.

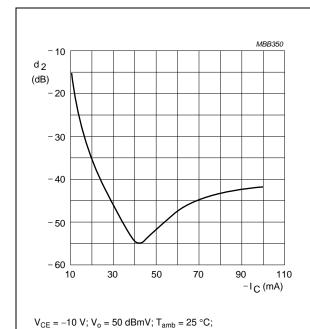
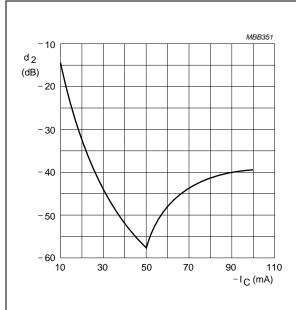


Fig.8 Second order intermodulation distortion as a function of collector current.



 $V_{CE} = -10 \text{ V; } V_o = 50 \text{ dBmV; } T_{amb} = 25 \text{ °C; } \\ f_{(p+q)} = 810 \text{ MHz.}$ 

Fig.9 Second order intermodulation distortion as a function of collector current.

 $f_{(p+q)} = 450 \text{ MHz}.$ 

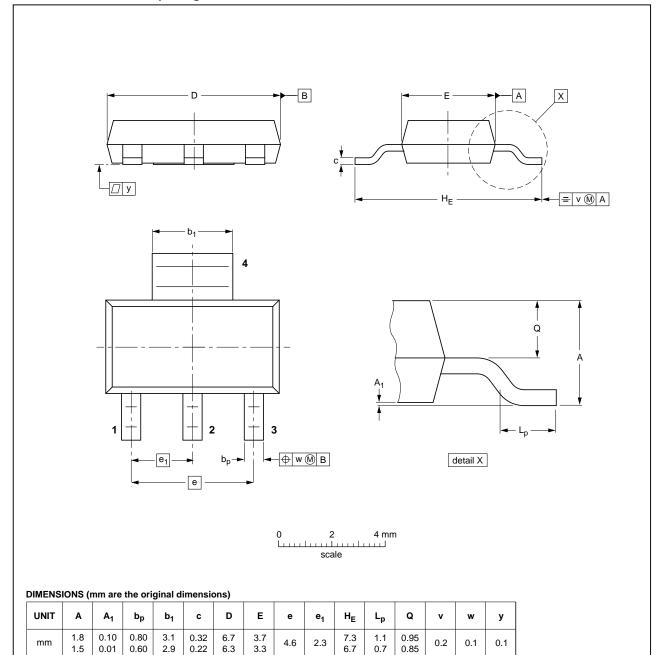
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## **PACKAGE OUTLINE**

Plastic surface-mounted package with increased heatsink; 4 leads

**SOT223** 



OUTLINE	REFERENCES			EUROPEAN	ISSUE DATE	
VERSION	IEC	JEDEC	JEITA		PROJECTION	ISSUE DATE
SOT223			SC-73			<del>-04-11-10</del> 06-03-16

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#### **DATA SHEET STATUS**

DOCUMENT STATUS(1)	PRODUCT STATUS <sup>(2)</sup>	DEFINITION
Objective data sheet	Development	This document contains data from the objective specification for product development.
Preliminary data sheet	Qualification	This document contains data from the preliminary specification.
Product data sheet	Production	This document contains the product specification.

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## **Contact information**

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